

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/561,596	PURKINS ET AL.	
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	EDMUND LEE	1744	

Search Notes



Application/Control No.

10/561,596

Examiner

EDMUND LEE

**Applicant(s)/Patent under
Reexamination**

PURKINS ET AL.

Art Unit

1744

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner